

| | | | | |
|-----------------------------------|---------------------------------------|--|---|-------------|
| Notice of References Cited | Application/Control No. 10/585,047 | | Applicant(s)/Patent Under Reexamination LUTZ ET AL. | |
| | Examiner JOHN K. KIM | | Art Unit 2834 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|--------------------|----------------|
| * | A | US-4,972,114 | 11-1990 | Frister, Manfred | 310/263 |
| * | B | US-5,708,318 | 01-1998 | Fudono, Kiyoshi | 310/263 |
| * | C | US-6,476,535 | 11-2002 | Oohashi et al. | 310/263 |
| * | D | US-2002/0096965 | 07-2002 | Ikeda et al. | 310/263 |
| * | E | US-6,114,793 | 09-2000 | Asao et al. | 310/263 |
| * | F | US-2003/0137214 | 07-2003 | Ishizuka et al. | 310/263 |
| * | G | US-3,714,484 | 01-1973 | Habert, Roger Jean | 310/263 |
| * | H | US-6,424,072 | 07-2002 | Armiroli et al. | 310/263 |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.